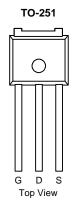


### FQU7P20-VB Datasheet

P-Channel 200-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
- 200	1.000 at V <sub>GS</sub> = - 10 V	- 5	76 nC		
- 200	1.200 at V $_{ m GS}$ = - 4.5 V	- 4.8	70110		



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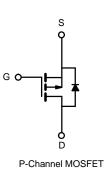
#### FEATURES

- Trench Power MOSFET
- 100 % UIS Tested

#### APPLICATIONS

Load Switch





Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V <sub>DS</sub>	- 200	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20		
	T <sub>C</sub> = 25 °C		- 5 <sup>a</sup>		
Continuous Drain Current (T $= 150$ °C)	T <sub>C</sub> = 70 °C		- 4.8		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	-5 <sup>b</sup>	A	
	T <sub>A</sub> = 70 °C		- 4.7 <sup>b</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	- 30	-	
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	- 35		
Single Pulse Avalanche Energy	L = 0.1 mm	E <sub>AS</sub>	101	mJ	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	L.	29 <sup>a</sup>	A	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	2.1 <sup>b</sup>	A .	
	T <sub>C</sub> = 25 °C		104.2 <sup>a</sup>		
Maximum Davier Disais ation	T <sub>C</sub> = 70 °C		66.7 <sup>a</sup>	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	3.1 <sup>b</sup>		
	T <sub>A</sub> = 70 °C		2 <sup>b</sup>	7	
Operating Junction and Storage Temperature Ra	ange	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b</sup>	Steady State	R <sub>thJA</sub>	33	40	°C/W	
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	0.98	1.2	C/W	

Notes:

a. Based on  $T_C = 25 \ ^{\circ}C$ .

b. Surface mounted on 1" x 1" FR4 board.

<b>SPECIFICATIONS</b> ( $T_J = 25 \ ^{\circ}C$ ,	unless othe	rwise noted)					
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = -250 \mu A$	- 200			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μΑ		68		mV/°0	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	5		- 5.2			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 1.7		- 3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zana Oata Maltana Duain Oumant	I <sub>DSS</sub>	$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1	μA	
Zero Gate Voltage Drain Current		$V_{DS}$ = - 60 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 °C			- 10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} = -5 V, V_{GS} = -10 V$	- 120			A	
	_	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 30 A		1.000			
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 20 A		1.200		Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 50 A	20			S	
Dynamic <sup>b</sup>	1			1	1		
Input Capacitance	C <sub>iss</sub>			3500			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz		390		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			290			
Takal Oaka Okanan		$V_{DS}$ = - 30 V, $V_{GS}$ = - 10 V, $I_{D}$ = - 55 A	76		115		
Total Gate Charge	Qg			38	60		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = - 30 V, $V_{GS}$ = - 4.5 V, $I_{D}$ = - 55 A		16		nC	
Gate-Drain Charge	Q <sub>gd</sub>			19		1	
Gate Resistance	Rg	f = 1 MHz		5.2		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			10	15		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 2 V, $R_L$ = 2 $\Omega$		7	15	- ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		70	110		
Fall Time	t <sub>f</sub>			40	60	1	
Drain-Source Body Diode Characteristic	s					<u> </u>	
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			- 66		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 150	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 30 A		- 1	- 1.5	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			45	68	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			59	120	nC	
Reverse Recovery Fall Time	ta	I <sub>F</sub> = - 50 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		29			
Reverse Recovery Rise Time	t <sub>b</sub>			16		ns	

Notes:

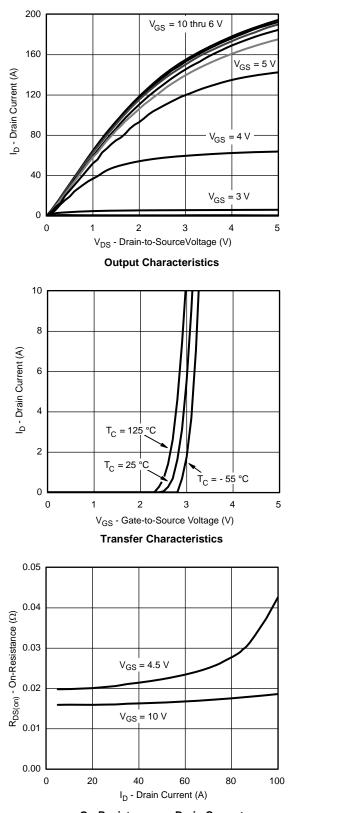
a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

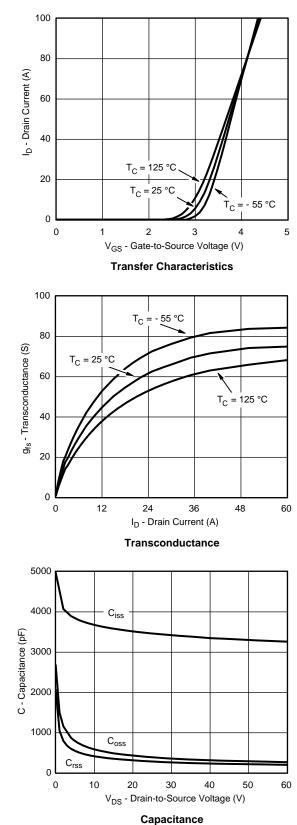
VBsemi Bsemi.com



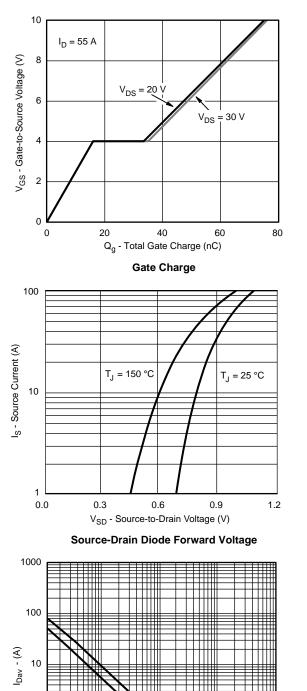


#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

**On-Resistance vs. Drain Current** 







at T<sub>J</sub> = 25

0.1

C

1

(A)

 $I_{AV}$  (A) at  $T_{J}$  = 150

0.001

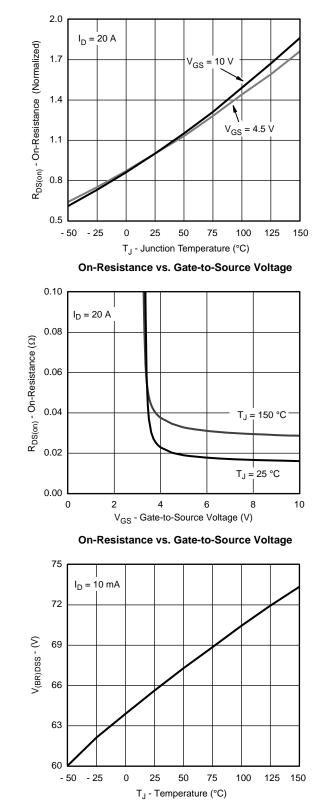
11111

0.01

T<sub>in</sub> - (s)

Single Pulse Avalanche Current Capability vs. Time

#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



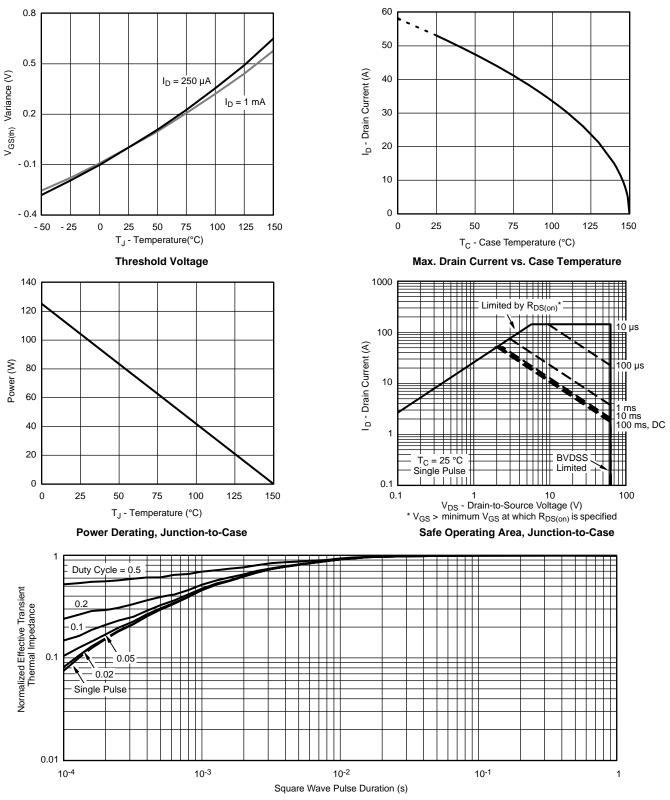
Drain-Source Breakdown Voltage vs. Junction Temperature

1

0.1

0.0001



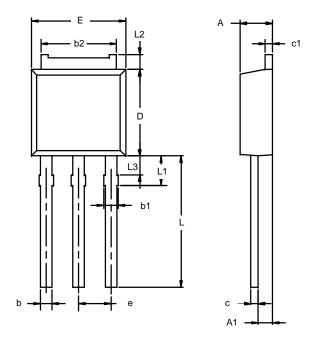


#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





#### TO-251AA (DPAK)



Note: Dimension L3 is for reference only.

	MILLIN	IETERS	INCHES		
Dim	Min	Мах	Min	Max	
Α	2.21	2.38	0.087	0.094	
A1	0.89	1.14	0.035	0.045	
b	0.71	0.89	0.028	0.035	
b1	0.76	1.14	0.030	0.045	
b2	5.23	5.43	0.206	0.214	
С	0.46	0.58	0.018	0.023	
c1	0.46	0.58	0.018	0.023	
D	5.97	6.22	0.235	0.245	
Е	6.48	6.73	0.255	0.265	
е	2.28	BSC	0.090	BSC	
L	8.89	9.53	0.350	0.375	
L1	1.91	2.28	0.075	0.090	
L2	0.89	1.27	0.035	0.050	
L3	1.15	1.52	0.045	0.060	



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